## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

ın re P	aler	IL A	oplica	luon or:	
Sung-`	Your	n Cł	HO et	al.	
Applica	atior	n No	o.:		Group Art Unit:
Filed:	Mar	ch (	3, 200	)4	Examiner:
For:	ME	TH	A DC	ND APPARATUS OF PROCES	SING DATA ACCORDING TO DATA TYPES
				INFORMATION DISCLOS	SURE STATEMENT
PO Bo	x 14	150		Patents 13-1450	
Sir:					
the su	ed c bjec	erta t U.:	in info S. pa	ormation which the Examiner m	ovisions of 37 CFR § 1.56, there is hereby ay consider material to the examination of that the Examiner make this information of f the subject application.
	1.		Encl	osures accompanying this Infor	mation Disclosure Statement are:
			$\overline{\boxtimes}$	application or a PCT Internatio English language translation (c each non-English language pu Explanations of Relevancy of F	complete or relevant portion(s)) attached to
	2.				a concise explanation of what is presently each non-English language publication is
	:	2a.		enclosed "English-language verindicates the degree of relevant 609, Minimum Requirements for A(3): Concise Explanation of Refeb. 2000.)	s 2a, 2b, 2c and/or 2d) sh language publications were cited on the ersion of the search report or action which ace found by the foreign office". (See MPEP or an Information Disclosure Statement, Part Relevance, pp. 600-100 to 600-101, Rev. 1,
		2b.		set forth in the application.	

).
ed in this Statement is, or is considered ration that a search has been made rt foreign application or a PCT with). 37 CFR §§ 1.97(g) and (h).
submitted,
ALSEY LLP
Michael D. Stein Registration No. 37,240
e a r :\

FΩ	RM	P7	ر 1-01	1449
-	T IV	-	1 ( )~	

## U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.	APPLICATION NO.	
1793.1065		
FIRST NAMED INVENTOR		
Sung-Youn CHO et al.		
FILING DATE	GROUP ART UNIT	

March 3, 2004

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

HIS DATENT DOCUMENTS

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

**FOREIGN PATENT DOCUMENTS** 

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSL YES	ATION NO
AG	2002-90223	11/30/02	Korea			Abst	
АН							
Al					-		
AJ						_	
AK							
AL							

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

AM			
AN			
AO			

EXAMINER	DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.